

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination	
	10/749,554	LIN ET AL.	
Examiner	Julio R. Perez	Art Unit	2617

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
PGPUB	Text	7/19/2007	JP
370	331 332 236	7/19/2007	JP
370	338 348	7/19/2007	JP
455/452.2, 422, 436		7/19/2007	JP